

<b>Notice of References Cited</b>	Application/Control No. 10/784,186	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Thanh T. Nguyen	Art Unit 2813	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,103,630	08-2000	Lee et al.	438/696
X	B	US-2004/0119170	06-2004	Kim et al.	257/775
X	C	US-6,033,981	03-2000	Lee et al.	438/624
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

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